

14849 Firestone Boulevard · La Mirada, CA 90638
 Phone: (714) 670-SSDI (7734) · Fax: (714) 522-7424

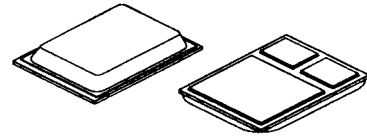
Designer's Data Sheet

FEATURES:

- Rugged construction with polysilicon gate
- Low RDS(on) and high transconductance
- Excellent high temperature stability
- Very fast switching speed
- Fast recovery and superior dv/dt performance
- Increased reverse energy capability
- Low input and transfer capacitance for easy paralleling
- Ceramic Seals for improved hermeticity
- Hermetically sealed surface mount power package
- TX, TXV and Space Level screening available
- Replaces: IXTH11N80 Types

**11 AMPS
 800 VOLTS
 0.95Ω
 N-CHANNEL
 POWER MOSFET**

MILPACK 2



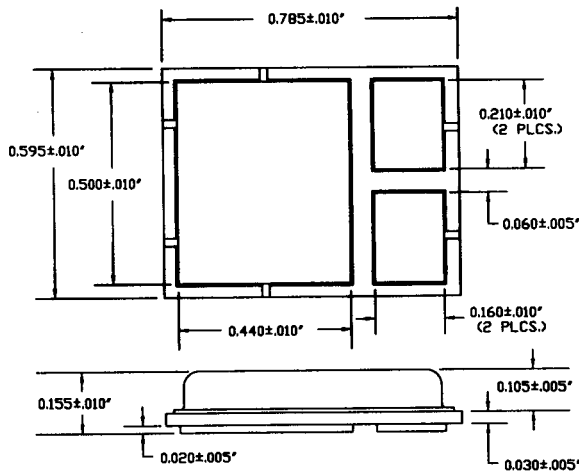
MAXIMUM RATINGS

CHARACTERISTIC	SYMBOL	VALUE	UNIT
Drain to Source Voltage	V _{DS}	800	Volts
Gate to Source Voltage	V _{GS}	±20	Volts
Continuous Drain Current	I _D	11	Amps
Operating and Storage Temperature	Top & Tstg	-55 to +175	°C
Thermal Resistance, Junction to Case	R _{θJC}	0.5	°C/W
Total Device Dissipation @ TC=25°C	P _D	250	Watts
Total Device Dissipation @ TC=55°C		190	

PACKAGE OUTLINE: MILPACK 2

PIN OUT:

- PIN 1: DRAIN
 PIN 2: SOURCE
 PIN 3: GATE**



NOTE: All specifications are subject to change without notification. SCD's for these devices should be reviewed by SSDI prior to release.

DATA SHEET #: F00221 B

MED

SFF11N80B

PRELIMINARY

**SOLID STATE DEVICES, INC**14849 Firestone Boulevard · La Mirada, CA 90638
Phone: (714) 670-SSDI (7734) · Fax: (714) 522-7424**ELECTRICAL CHARACTERISTICS @ T_J=25 °C (Unless Otherwise Specified)**

RATING		SYMBOL	MIN	TYP	MAX	UNIT
Drain to Source Breakdown Voltage (VGS=0 V, ID=250μA)		BVDSS	800	---	---	V
Drain to Source on State Resistance (VGS=10 V, ID=50% Rated ID)		RDS(on)	---	---	0.95	Ω
On State Drain Current (VDS > ID(on) X RDS(on) Max, VGS=10 V)		ID(on)	11	---	---	A
Gate Threshold Voltage (VDS=VGS, ID=250μA)		VGS(th)	2.0	---	4.5	V
Forward Transconductance (VDS > ID(on) X RDS(on) Max, IDS=50% rated ID)		gfs	8.0	14	---	S(τ)
Zero Gate Voltage Drain Current (VDS=max rated voltage, VGS=0 V) (VDS=80% rated VDS, VGS=0 V, TA=125°C)		IDSS	---	---	250 1000	μA
Gate to Source Leakage Forward Gate to Source Leakage Reverse	At rated VGS	IGSS	---	---	+100 -100	nA
Total Gate Charge Gate to Source Charge Gate to Drain Charge	VGS=10 Volts 80% rated VDS 50% Rated ID	Qg Qgs Qgd	---	128 30 55	155 45 80	nC
Turn on Delay Time Rise Time Turn Off Delay Time Fall Time	VDD=50% rated VDS 50% rated ID RG=2.0Ω	td(on) tr td(off) tf	---	20 33 63 32	50 50 100 50	nsec
Diode Forward Voltage (IS=rated ID, VGS=0 V, T _J =25°C)		VSD	---	---	1.5	V
Diode Reverse Recovery Time Reverse Recovery Charge	T _J =25°C IF=rated ID di/dt=100 A/μsec	trr QRR	---	250 ---	---	nsec μC
Input Capacitance Output Capacitance Reverse Transfer Capacitance	VGS=0 Volts VDS=25 Volts f= 1 MHz	Ciss Coss Crss	---	4200 360 100	---	pF

For thermal derating curves and other characteristic curves please contact SSDI Marketing Department.